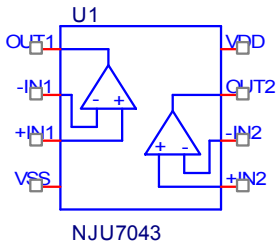
Device Modeling Report

COMPONENTS : OPERATIONAL AMPLIFIER (CMOS)
PART NUMBER : NJU7043
MANUFACTURER : NEW JAPAN RADIO

Bee Technologies Inc.

Spice Model

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*PART NUMBER: NJU7043
*MANUFACTURER: NEW JAPAN RADIO
*CMOS OPAMP
*All Rights Reserved Copyright (c) Bee Technologies Inc. 2007
.SUBCKT nju7043 OUT1 -IN1 +IN1 VSS +IN2 -IN2 OUT2 VDD
X_U1 +IN1 VSS -IN1 OUT1 VDD nju7043_s
X_U2 +IN2 VSS -IN2 OUT2 VDD nju7043_s
.ENDS nju7043
.SUBCKT nju7043_s    IN+ VSS IN- OUT VDD
M1              2 IN- 3 VDD MbreakPD3
M2              2 IN+ 4 VDD MbreakPD2
M3              VDD 1 2 VDD MbreakPD4
M4              VDD 1 5 VDD MbreakPD
M5              VDD 1 6 VDD MbreakPD
M6              VDD 1 1 VDD MbreakPD
M7              5 5 VSS VSS MbreakND
M8              5 4 VSS VSS MbreakND
M9              3 3 IN1 VSS MbreakND4
M10             4 3 IN2 VSS MbreakND1
M11             1 6 11 11 MbreakND
M12             6 6 VSS VSS MbreakND3
M13             7 5 VSS VSS MbreakND5
M14             VDD 7 7 VDD MbreakPD
M15             VDD 7 OUT VDD MbreakPD1
M16             OUT 4 VSS VSS MbreakND2
C1              OUT 4 90p
C2              OUT 6 7.2p
R1              11 VSS    1.522k
R2              IN1 VSS 2.0k
R3              IN2 VSS    2.423k
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I1              0 IN-    0.505p
I2              0 IN+    1.5p
X_U1              VSS 3 DbreakZ
X_U2              VSS 4 DbreakZ
.model MbreakND NMOS (LEVEL=3 L=6u W=3.2m VTO=0.2 RS=10E-3
+ RD=10E-3 RDS=1.00E6 TOX=2.00E-6 RG=5 RB=1.0000E-3 KP=1E-6)
.model MbreakND1 NMOS (LEVEL=3 L=6u W=0.165 VTO=0.2 RS=10E-3
+ RD=10E-3 RDS=1.00E6 TOX=2.00E-6 RG=5 RB=1.0000E-3 KP=1E-6)
.model MbreakND2 NMOS (LEVEL=3 L=6u W=27.4m VTO=0.2 RS=10E-3
+ RD=10E-3 RDS=1.00E6 TOX=2.00E-6 CGSO=1E-10 CGDO=300e-12
+ CBD=45.0E-12 RG=5 RB=1.0000E-3 KP=1E-6)
.model MbreakND3 NMOS (LEVEL=3 W=3.2m L=6u VTO=0.1 RS=10E-3
+ RD=10E-3 RDS=1E6 TOX=2.00E-6 RG=5 RB=1.00E-3 KP=1E-6)
.model MbreakND4 NMOS (LEVEL=3 L=6u W=0.165 VTO=0.2 RS=10E-3
+ RD=10E-3 RDS=1.00E6 TOX=2.00E-6 CGSO=1E-8 CBD=100.00E-12
+ RG=5 RB=1.0000E-3 KP=1E-6)
.model MbreakND5 NMOS (LEVEL=3 L=6u W=0.165 VTO=0.2 RS=10E-3
+ RD=10E-3 RDS=1.00E6 TOX=2.00E-6 RG=5 RB=1.0000E-3 KP=1E-6)
.model MbreakPD PMOS (LEVEL=3 L=6u W=0.23 VTO=-0.1 RS=10.0E-3
+ RD=10E-3 RDS=1.00E6 TOX=2.00E-6 RG=5 RB=1.0000E-3 KP=1E-6)
.model MbreakPD1 PMOS (LEVEL=3 L=6u W=0.4 VTO=-0.1 RS=10.0E-3
+ RD=10E-3 RDS=1E6 TOX=2E-6 CGDO=1.9E-8 RG=5 RB=1E-3 KP=1E-6)
.MODEL MbreakPD2 PMOS (LEVEL=3 L=6u W=0.00175 VTO=-.34 RS=10E-3
+ RD=10E-3 RDS=2.1E6 TOX=2E-6 CBD=10E-12 RG=5 RB=1E-3 KP=1E-5)
.MODEL MbreakPD3 PMOS (LEVEL=3 L=6u W=0.00177 VTO=-.34 RS=10E-3
+ RD=10E-3 RDS=1.0E6 TOX=2.0E-6 RG=5 RB=1.0000E-3 KP=1E-5)
.model MbreakPD4 PMOS (LEVEL=3 W=.23 L=0.3u VTO=-0.1 RS=10E-3
+ RD=10E-3 RDS=1E6 TOX=2E-6 CGDO=1.2e-10 RG=5 RB=1E-3 KP=1E-6)
.ENDS nju7043_s
.SUBCKT DbreakZ    A K
D1 A K DF
DZ A2 A DR
VZ K A2 1
.MODEL DF D
.MODEL DR D
.ENDS DbreakZ
*$
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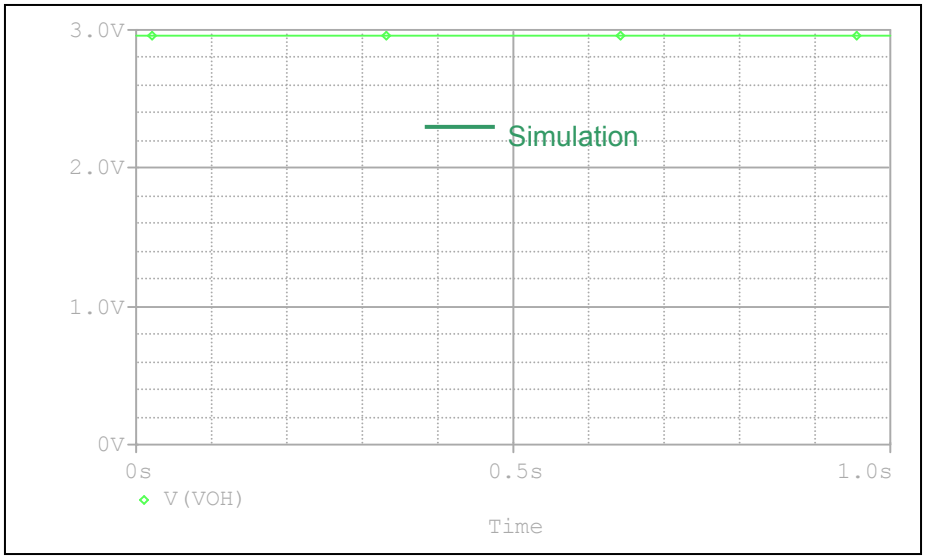
MOSFET MODEL

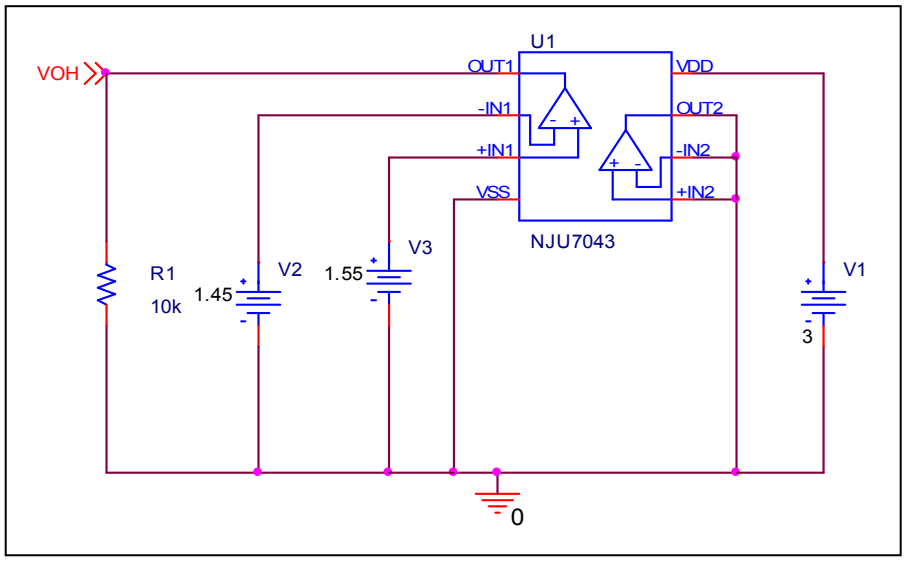
Pspice model parameter	Model description
LEVEL	
L	Channel Length
W	Channel Width
KP	Transconductance
RS	Source Ohmic Resistance
RD	Ohmic Drain Resistance
VTO	Zero-bias Threshold Voltage
RDS	Drain-Source Shunt Resistance
TOX	Gate Oxide Thickness
CGSO	Zero-bias Gate-Source Capacitance
CGDO	Zero-bias Gate-Drain Capacitance
CBD	Zero-bias Bulk-Drain Junction Capacitance
MJ	Bulk Junction Grading Coefficient
PB	Bulk Junction Potential
FC	Bulk Junction Forward-bias Capacitance Coefficient
RG	Gate Ohmic Resistance
IS	Bulk Junction Saturation Current
N	Bulk Junction Emission Coefficient
RB	Bulk Series Resistance
PHI	Surface Inversion Potential
GAMMA	Body-effect Parameter
DELTA	Width effect on Threshold Voltage
ETA	Static Feedback on Threshold Voltage
THETA	Modility Modulation
KAPPA	Saturation Field Factor
VMAX	Maximum Drift Velocity of Carriers
XJ	Metallurgical Junction Depth
UO	Surface Mobility

Output Voltage Swing (V_{OH1})

Simulation result



Evaluation Circuit



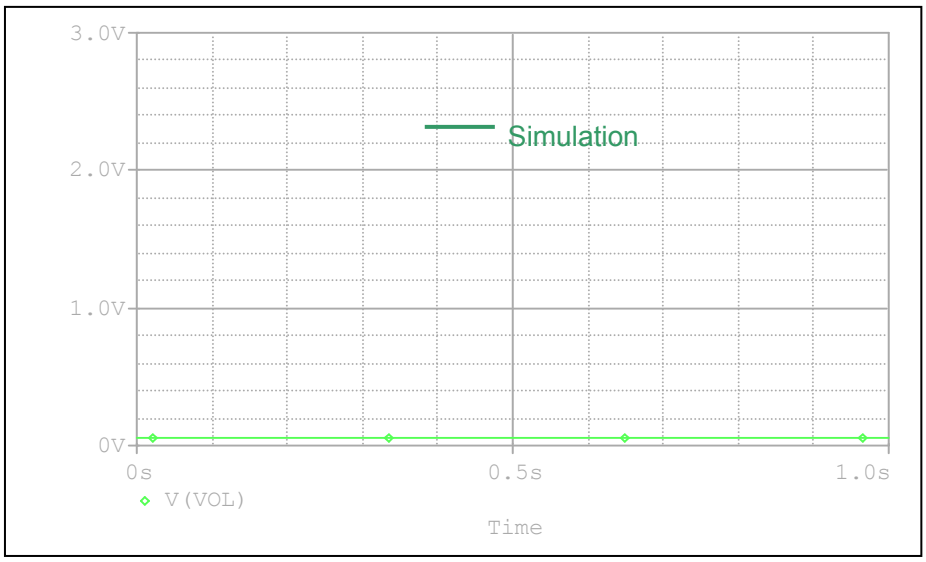
VIN+ = (VDD/2) + 0.05, VIN- = (VDD/2) - 0.05

Comparison Table

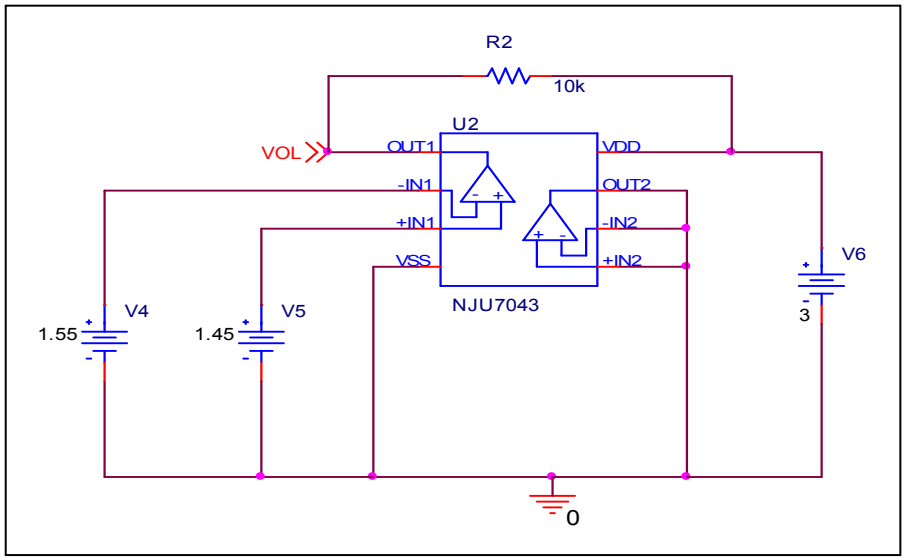
RL=10KΩ	Measurement	Simulation	%Error
V_{OH1} (V)	2.95	2.9532	0.108

Output Voltage Swing (V_{OL1})

Simulation result



Evaluation Circuit



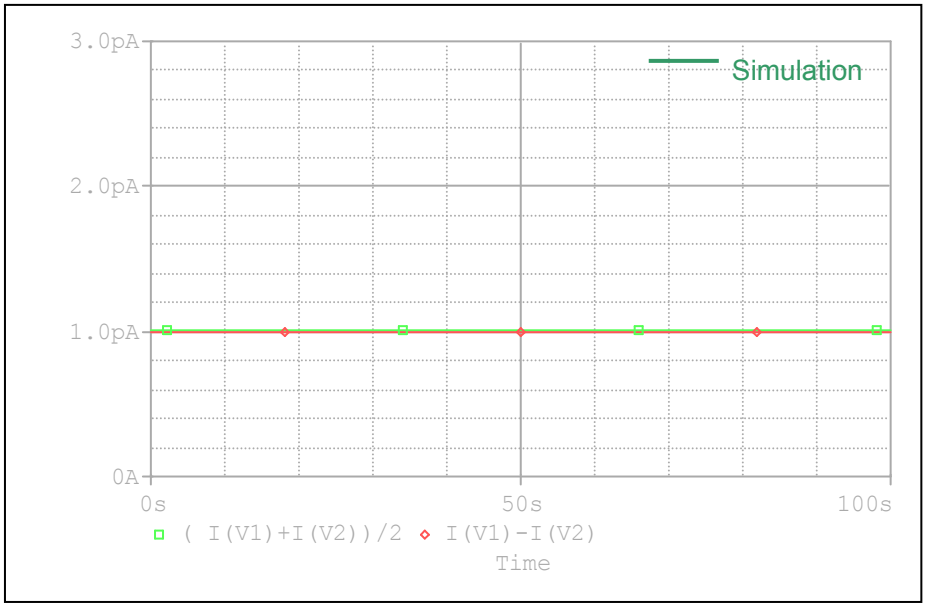
VIN+ = (VDD/2) - 0.05, VIN- = (VDD/2) + 0.05

Comparison Table

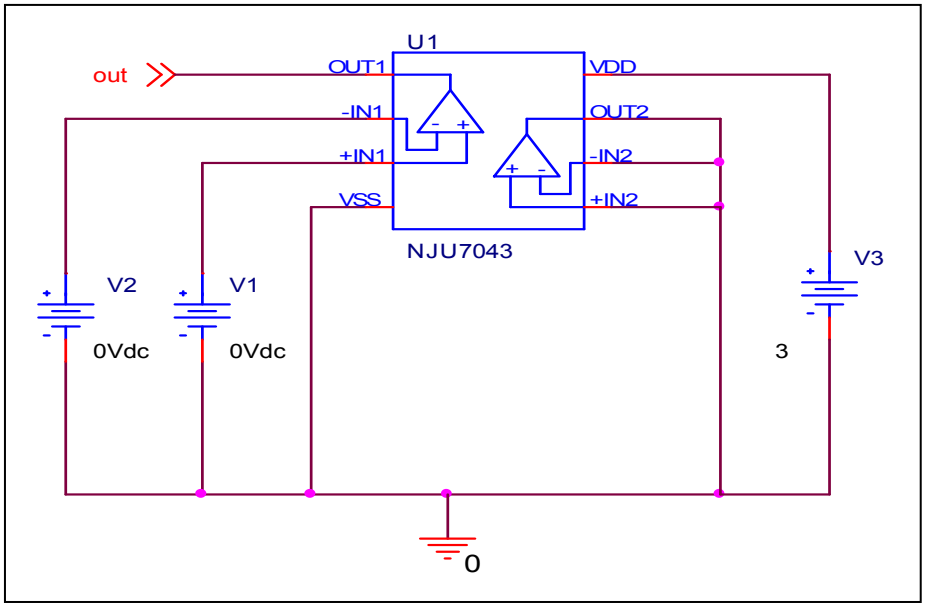
RL=10KΩ	Measurement	Simulation	%Error
V_{OL1} (V)	0.05	0.049225	-1.550

Input Current

Simulation result



Evaluation Circuit

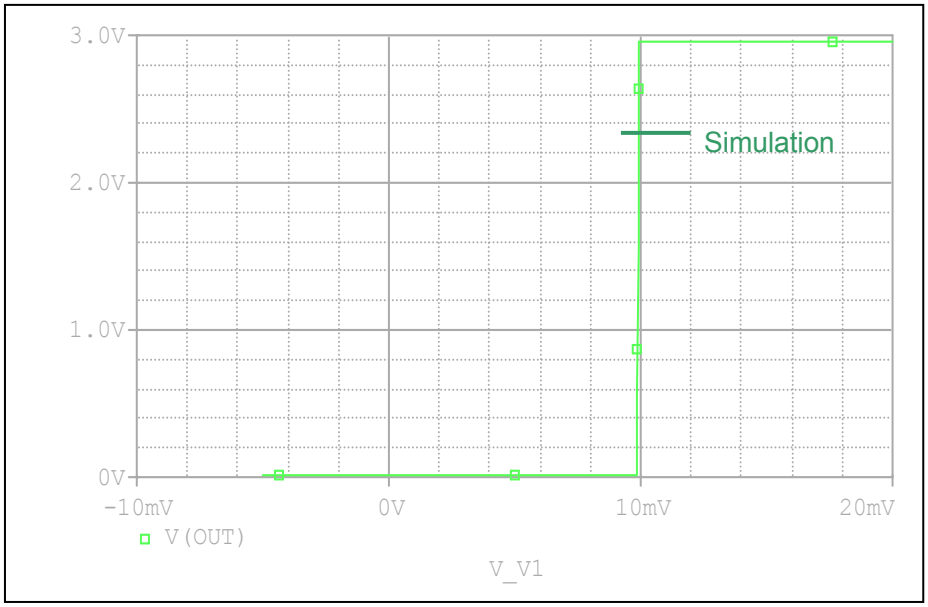


Comparison Table

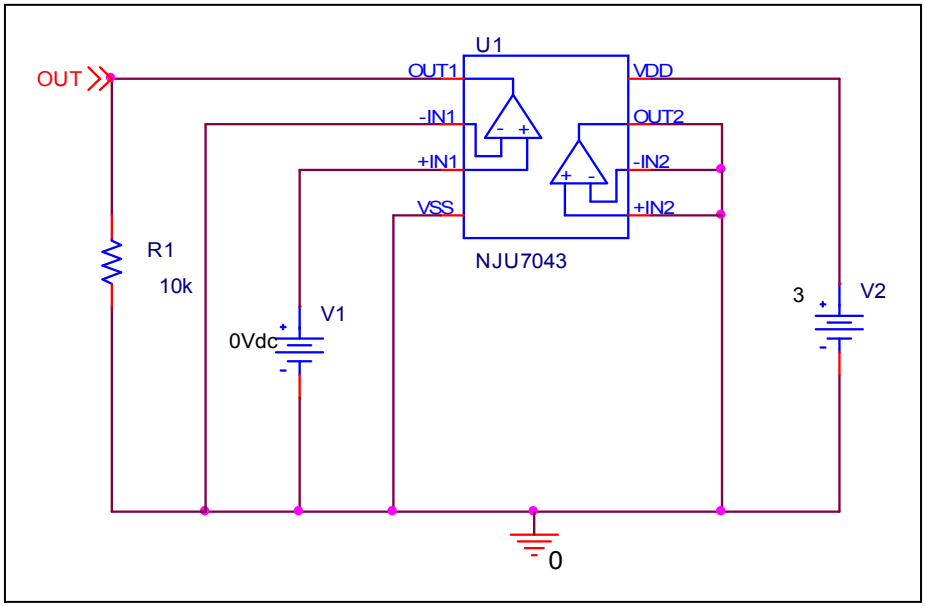
	Measurement	Simulation	% Error
I_b (pA)	1	1.0025	0.25
I_{os} (pA)	1	0.995	-0.5

Input Offset Voltage

Simulation result



Evaluation Circuit

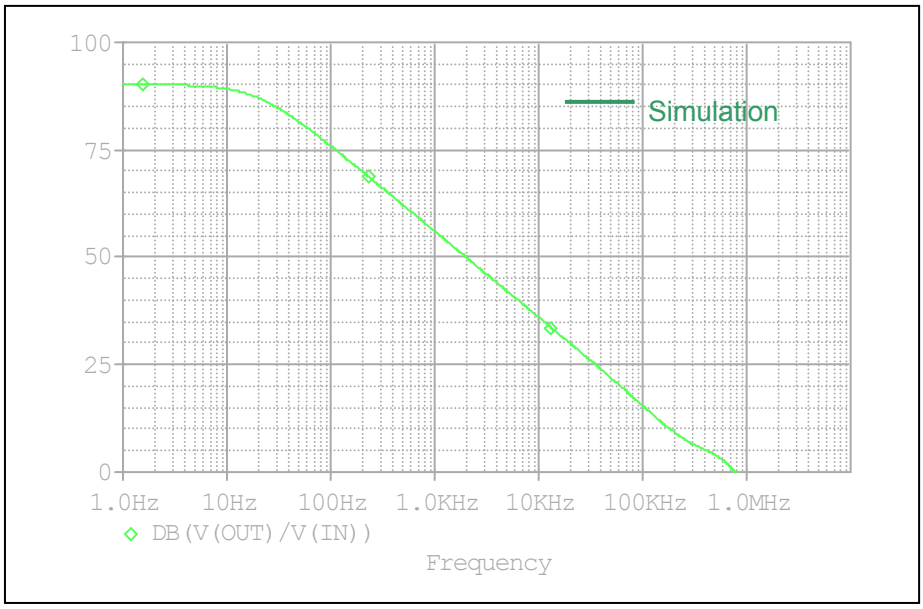


Comparison Table

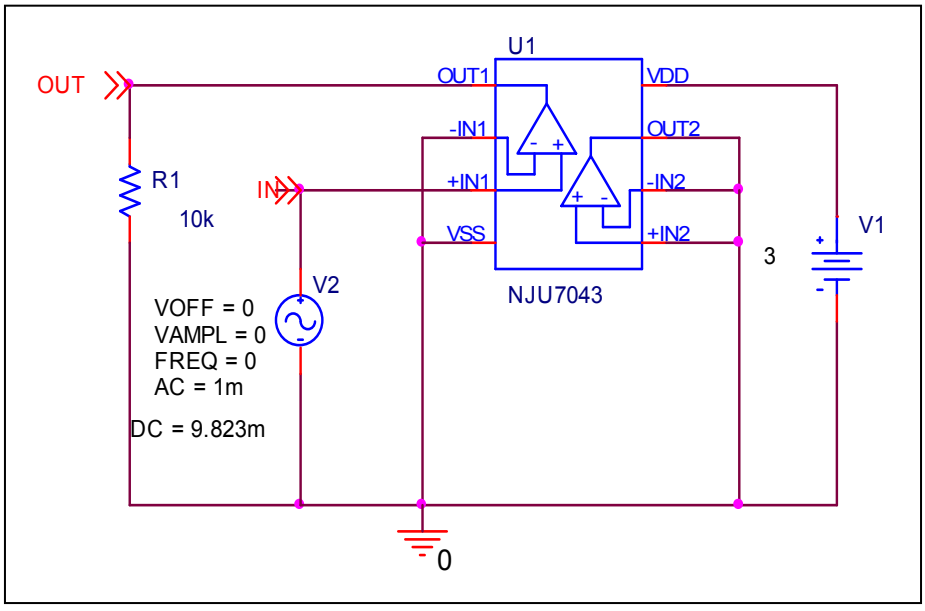
	Measurement	Simulation	%Error
V_{IO} (mV)	10	9.823	-1.770

Open loop Voltage Gain

Simulation result



Evaluation Circuit

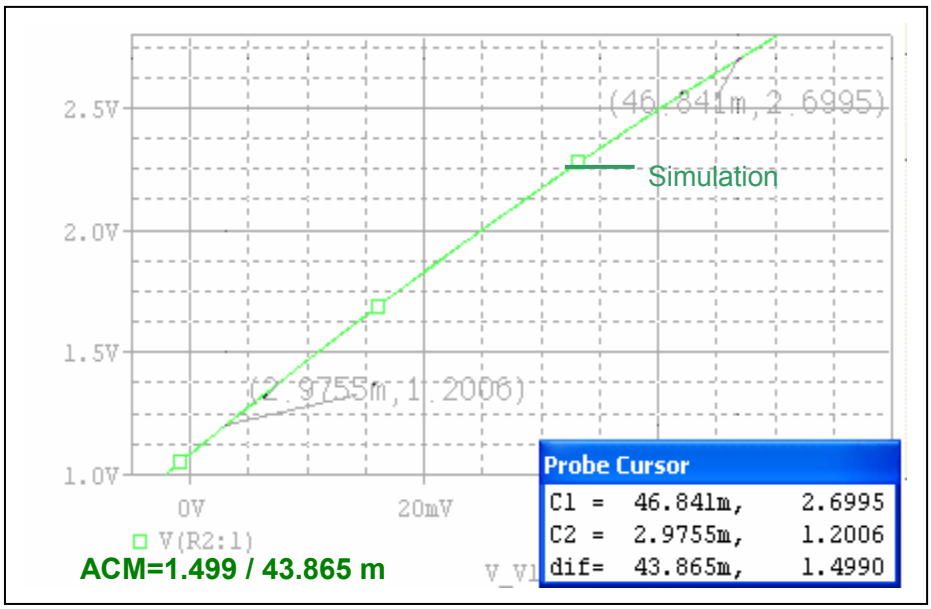


Comparison Table

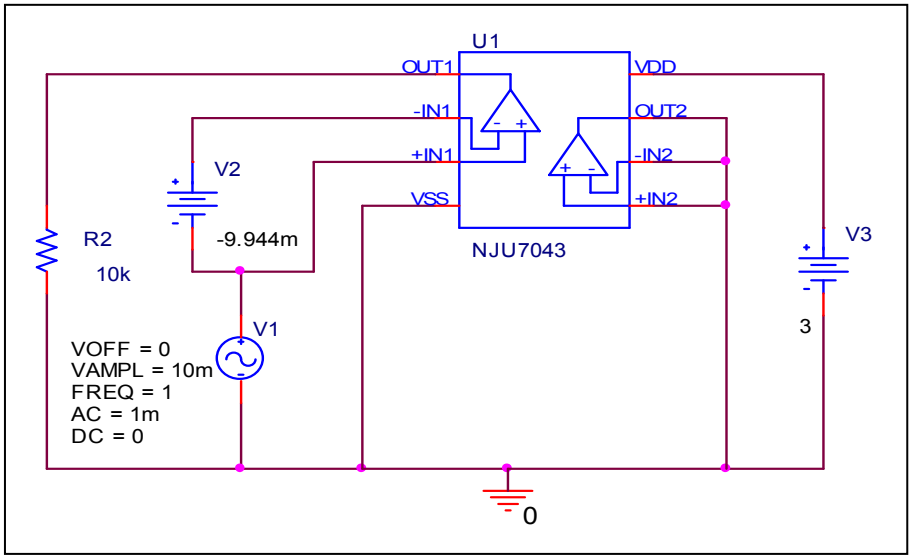
	Measurement	Simulation	%Error
Av (dB)	90	90.184	0.204
Ft (MHz)	0.8	0.779305	-2.587

Common-Mode Rejection Ratio

Simulation result



Evaluation Circuit



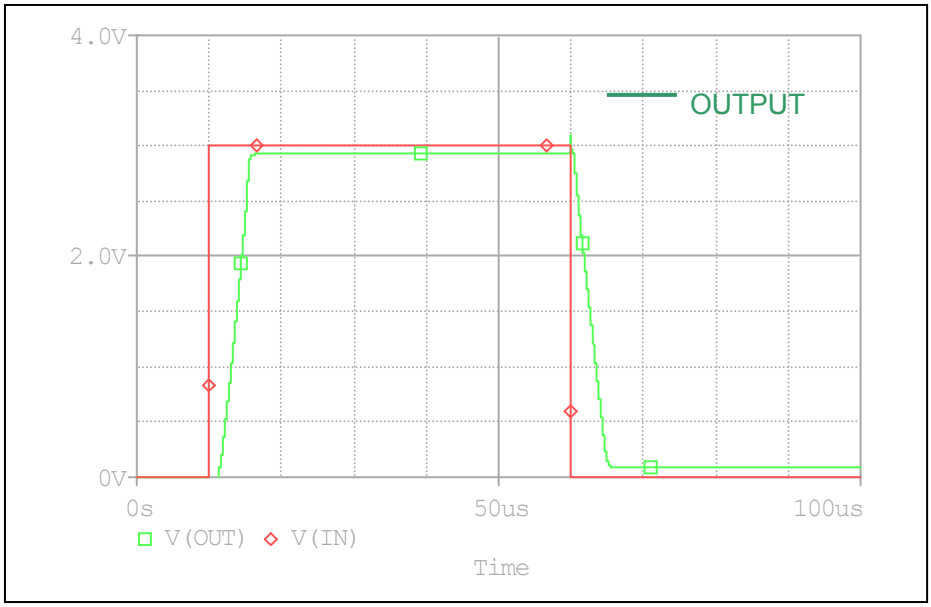
CMRR = AV/ACM

Comparison Table

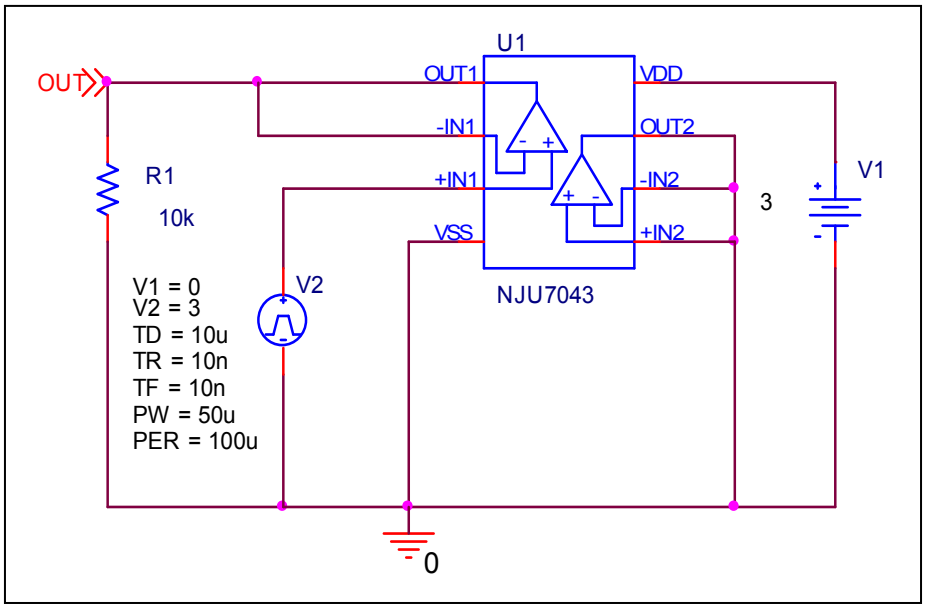
	Measurement	Simulation	%Error
CMRR (dB)	60	59.326	-1.123

Slew Rate

Simulation result



Evaluation Circuit



Comparison Table

	Measurement	Simulation	%Error
SR (V/us)	0.7	0.6998	-0.029